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INFORMATION DISCLOSURE CITATION
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ATTY DOCKET NO.
 142-03

SERIAL NO.
 10/749,680

Ming L. Shiao, et al.

FILING

December 31, 2003

GROUP

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/LK/	5,962,143	10/05/99	Krauthauser, et al.			
	6,174,360	01/16/01	Sliwinski, et al.			
	6,366,397	04/02/02	Genjima, et al.			
	6,376,075	04/23/02	Tacke-Willemsen, et al.			
	6,454,848	09/24/02	Sliwinski, et al.			
	6,521,038	02/18/03	Yanagimoto, et al.			
	6,533,961	03/18/03	Harelstad, et al.			
	6,548,145	04/15/03	Joedicke			
	6,569,520	05/27/03	Jacobs			
	6,572,784	06/03/03	Coombs, et al.			
/LK/	6,596,070	07/22/03	Schmidt, et al.			

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

/LK/		L. Sung, et al., "Characterization of Coating Microstructure Using Laser Scanning Confocal Microscopy," undated.
/LK/		Adobe Systems Incorporated, Technical Guides "Color Models, The CIE Color Models," 2 pgs. 2000.

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/LK/	6,599,355	07/29/03	Schmidt, et al.			
	6,607,781	09/19/03	Joedicke			
	2002/0160151	10/31/02	Pinault, et al.			
	2003/0035972	02/20/03	Hanson, et al.			
	2003/0044525	03/06/03	Aschenbeck			
	2003/0068469	04/10/03	Aschenbeck, et al.			
	2003/0091795	05/15/03	Kiik, et al.			
/LK/	2003/0152747	08/14/03	Fensel, et al.			

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						YES	NO

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

/LK/			Adobe Systems Incorporated, Technical Guides "Color Models, The Munsell Color System," 4 pgs., 2000.
/LK/			Adobe Systems Incorporated, Technical Guides "Color Models, CIELAB," 2 pgs., 2000.

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OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>						
/LK/			Gaco Western Inc., "Solar Reflectivity of Common Roofing Materials and GacoFlex Roof Coatings," 2 pgs., undated.			
/LK/			BASF Aktiengesellschaft, "Product Specification, SICOLUX Metal Gloss L 6015," 1 pg., September 18, 2002.			
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<i>/LK/ [Signature]</i>			07/07			

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